



Fizeau high definition interferometer with patented QPSI™ acquisition for true on-axis common path metrology of optical surfaces or wavefront in the presence of vibration.

Syst		

Measurement Measures surface form of reflective materials and optics, and transmitted Capability

wavefront of transparent optics

Data Acquisition Modes PSI- temporal phase-shifting

interferometry

QPSI- vibration robust temporal phase-

shifting interferometry

DynaPhase™-vibration insensitive instantaneous interferometry (option)

Quick Fringe Acquisition System (QFAS) Alignment System

with twin spot reticle

Test Beam Diameter 4 inch (102 mm) or 6 inch (152 mm)

Alignment FOV 4 inch: ±3 degrees 6 inch: ±2 degrees

Optical Centerline 4.25 in. (108 mm)

Resolution: 2304 x 2304 pixels Camera Details Frame Rate: 210 Hz

Digitization: 8 bit

Shutter Time: 200 µs - 10 ms

Acquisition Time 130 - 300 ms

> Magnification 1X Fixed (1-50X digital)

Polarization Nominally circular (1.2:1 or better)

4 inch: ±2 m Pupil Focus Range

6 inch: ±4.5 m

Computer and High-performance Dell PC, Windows 10

64-bit, Mx<sup>™</sup> software Software Mounting Configuration Horizontal or vertical

> Remote Control Wired and wireless remote with common

> > interferometer function controls

**Additional Options** CARS (Coherent Artifact Suppression)-

minimizes artifacts from wavefront shearing, speckle or mottle

See the ZYGO Laser Interferometer Accessories

Accessory Guide, OMP-0463

Physical Envelope 69 x 31 x 34 cm

(LWH) (27.3 x 12.1 x 13.4 in.) Weight ≤85 lb (38 kg)

Warranty 3 years laser source, 2 years system

LASER DETAILS

Laser Source High power stabilized HeNe

> Class IIIa (meets 3R ANSI requirements)

Wavelength 633 nm Frequency Stabilization

<0.0001 nm Output Power >3 mW Coherence Length >100 m

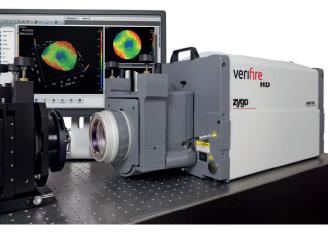
**UTILITY REQUIREMENTS** 

Power 100 to 240 VAC, 50/60 Hz

80 psi (5.5 bar); dry and filtered source Compressed Air

(required for optional vibration isolation)

Peak Pixel Deviation <sup>5</sup>



## OPERATIONAL ENVIRONMENT(1)

Temperature 15 to 30°C (59 to 86°F) Rate of

<1.0°C per 15 min Temp. Change

Humidity 5 to 95% relative, non-condensing Not required with QPSI; recommended Vibration Isolation

with PSI acquisition

Performance<sup>(2)</sup>

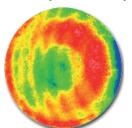
RMS Simple Repeatability 3 **RMS Wavefront** 

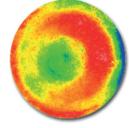
 $< 0.06 \text{ nm}, \lambda/10,000 (2\sigma)$ 

 $< 0.35 \text{ nm}, \lambda/1,800 \text{ (mean + } 2\sigma)$ Repeatability 4

 $<0.5 \text{ nm}, \lambda/1,200 (99.5^{\text{th}} \%)$ 

## Comparison of acquisitions in vibrating cavity





PSI 13 bucket algorithm

QPSI 5 ms shutter speed

## **Notations**

- These parameters outline the conditions under which the system can operate; they do not represent the environmental stability required to meet specified performance.
- Performance qualified with stable temperature set point between 20-23°C.
- RMS Simple Repeatability is defined by 2X the standard deviation of the RMS for 36 sequential measurements (16 averages) of a short 4 inch plano cavity.
- RMS Wavefront Repeatability is defined by the mean RMS difference plus 2X the standard deviation for the differential between all even numbered measurements and a synthetic reference (defined as the average of all odd numbered measurements); 36 sequential measurements (16 averages) form the basis for calculation.
- Peak Pixel Deviation is defined by the 99.5th percentile of the pixel-wise standard deviation map for 36 sequential measurements (16 averages); this result measures time varying behavior (or Type A uncertainties).



Specifications subject to change without prior notice.

